

NTJS3151PT1G-VB Datasheet P-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)			
	0.034 at $V_{GS} = -4.5 \text{ V}$	- 4				
- 20	0.045 at V _{GS} = - 2.5 V	- 4	12.5 nC			
	0.067 at V _{GS} = - 1.8 V	- 4				

SOT-363 SC-70 (6-LEADS)

FEATURES

 Halogen-free According to IEC 61249-2-21 Definition



RoHS

- Trench Power MOSFET
- 100 % R_g Tested
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Load Switch for Portable Devices
 - Cellular Phone
 - DSC
 - Portable Game Console
 - MP3
 - GPS

ABSOLUTE MAXIMUM RATINGS	(T _A = 25 °C, unle	ss otherwise not	ed)	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	- 20	V	
Gate-Source Voltage		V _{GS}	± 12	v
	T _C = 25 °C		- 4 ^a	
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 70 °C	1-	- 4	
Continuous Diain Curient (1) = 150°C)	T _A = 25 °C	I _D	- 4 ^{a, b, c}	
	T _A = 70 °C		- 4 ^{a, b, c}	A
Pulsed Drain Current (t = 300 μs)		I _{DM}	- 25	
Continuous Source-Drain Diode Current	T _C = 25 °C	I.	- 2.3	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	- 1.3 ^{b, c}	
	T _C = 25 °C		2.8	
Maximum Power Dissipation	T _C = 70 °C	P _D	1.8	w
Maximum Fower Dissipation	T _A = 25 °C	LD	1.6 ^{b, c}	
	T _A = 70 °C		1.0 ^{b, c}	
Operating Junction and Storage Temperature Rai	T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature)		260		

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient ^{b, d}	t ≤ 5 s	R _{thJA}	60	80	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	34	45	C/VV		

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under steady state conditions is 125 °C/W.



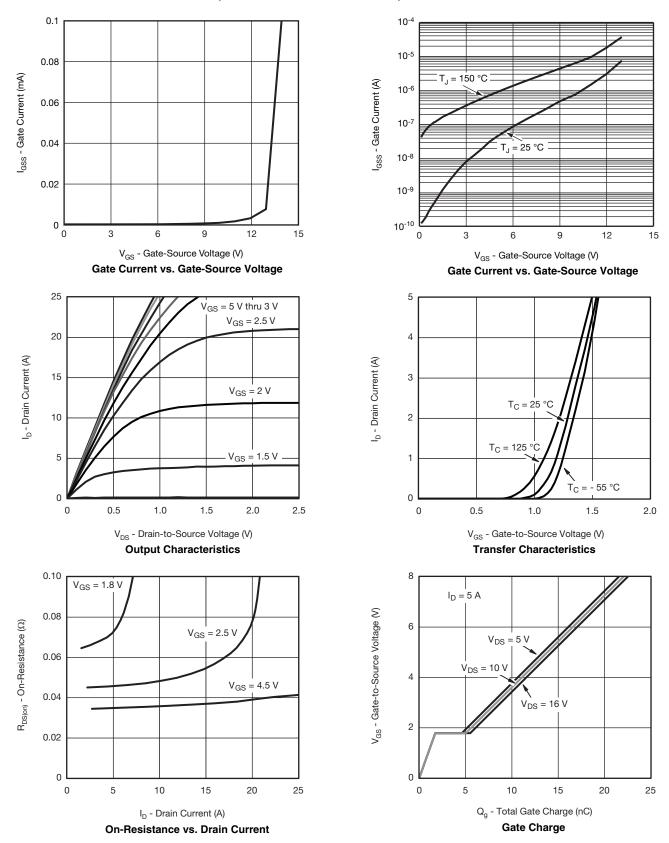
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static				L			
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	T,		- 11		m)//°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		2.6		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	- 0.4		- 1	V	
Gate-Source Leakage		$V_{DS} = 0 \text{ V}, V_{GS} = \pm 10 \text{ V}$			± 8	- μΑ	
	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 4.5 \text{ V}$			± 1		
7 0 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	_	V _{DS} = - 20 V, V _{GS} = 0 V			- 1		
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			- 10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 V$, $V_{GS} = -10 V$	- 15			Α	
		V _{GS} = - 4.5 V, I _D = - 5 A		0.034			
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 2.5 V, I _D = - 4.4 A		0.045		Ω	
		V _{GS} = - 1.8 V, I _D = - 1 A		0.067			
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 5 A		16		S	
Dynamic ^b							
Total Gate Charge		$V_{DS} = -10 \text{ V}, V_{GS} = -8 \text{ V}, I_D = -5 \text{ A}$		22	33	nC	
	Q _g			12.5	19		
Gate-Source Charge	Q _{gs}	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -5 \text{ A}$		1.8			
Gate-Drain Charge	Q _{gd}			3.3			
Gate Resistance	R_{g}	f = 1 MHz	0.08	0.43	0.86	kΩ	
Turn-On Delay Time	t _{d(on)}			150	225		
Rise Time	t _r	V_{DD} = - 10 V, R_L = 1.4 Ω		300	450		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -4 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		1620	2430		
Fall Time	t _f			560	840		
Turn-On Delay Time	t _{d(on)}			50	100	ns	
Rise Time	t _r	V_{DD} = - 10 V, R_L = 1.4 Ω		90	180		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -4 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		2500	3750		
Fall Time	t _f			600	900		
Drain-Source Body Diode Characterist	ics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 2.3		
Pulse Diode Forward Current	I _{SM}				- 25	Α	
Body Diode Voltage	V_{SD}	I _S = - 4 A, V _{GS} = 0 V		- 0.85	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			18	36	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			8	16	nC	
Reverse Recovery Fall Time	ta			18			
Reverse Recovery Rise Time	t _b			10		ns	

Notes:

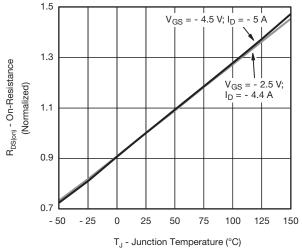
- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

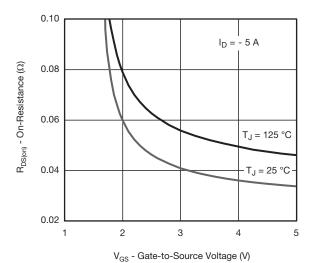




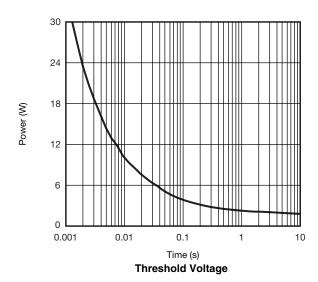


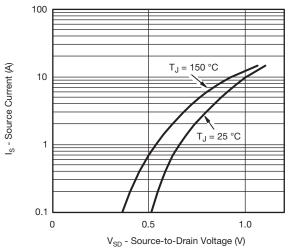


On-Resistance vs. Junction Temperature

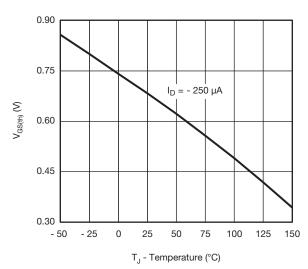


On-Resistance vs. Gate-to-Source Voltage

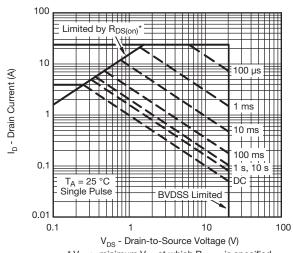




Source-Drain Diode Forward Voltage



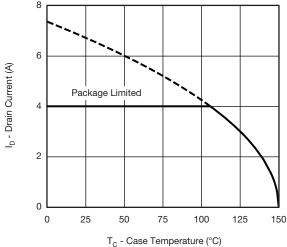
Single Pulse Power, Junction-to-Ambient



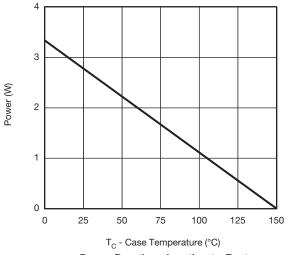
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

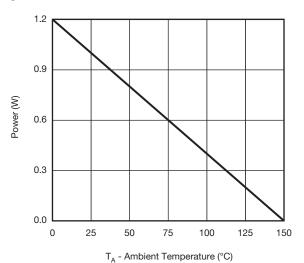
Safe Operating Area, Junction-to-Ambient





Current Derating*

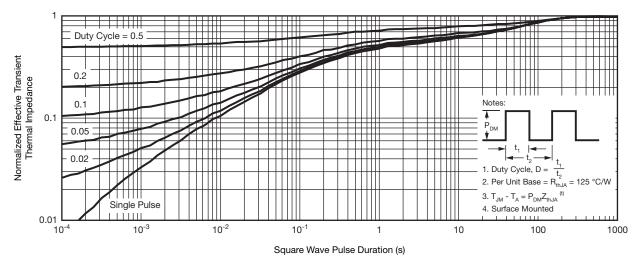




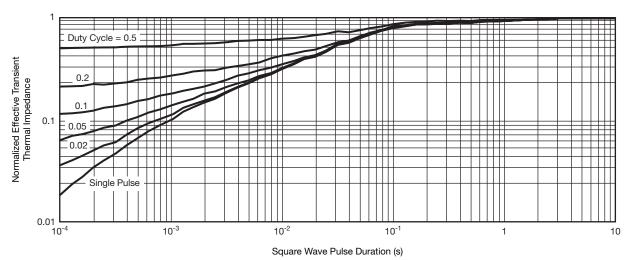
Power Derating, Junction-to-Foot Power Derating, Junction-to-Ambient

^{*} The power dissipation PD is based on TJ(max) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





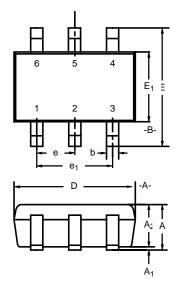
Normalized Thermal Transient Impedance, Junction-to-Ambient

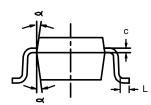


Normalized Thermal Transient Impedance, Junction-to-Foot



SC-70: 6-LEADS

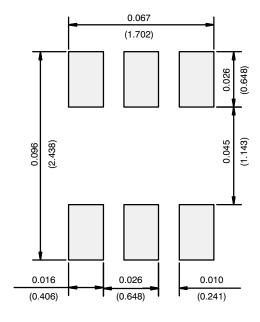




	MILLIMETERS			INCHES		
Dim	Min	Nom	Max	Min	Nom	Max
Α	0.90	_	1.10	0.035	-	0.043
A ₁	_	_	0.10	-	_	0.004
A ₂	0.80	-	1.00	0.031	-	0.039
b	0.15	_	0.30	0.006	_	0.012
С	0.10	-	0.25	0.004	-	0.010
D	1.80	2.00	2.20	0.071	0.079	0.087
E	1.80	2.10	2.40	0.071	0.083	0.094
E ₁	1.15	1.25	1.35	0.045	0.049	0.053
е	0.65BSC			0.026BSC		
e ₁	1.20	1.30	1.40	0.047	0.051	0.055
L	0.10	0.20	0.30	0.004	0.008	0.012
9	7°Nom			7°Nom		
ECN: S-03946—Rev. B, 09-Jul-01 DWG: 5550						



RECOMMENDED MINIMUM PADS FOR SC-70: 6-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)



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